## **1 Supplementary Materials**

### **Risk of AF**

We identify the risk of developing atrial fibrillation in a model with the probability,  $P_{\text{risk}}$ , that the  $L \times L$  system has at least one portion of the reentrant circuit as displayed in Fig. 2(e). In our simple model, we can calculate  $P_{\text{risk}}$ analytically. The probability that a transverse coupling exists is given by  $\nu$ . The probability that a cell has at least one transverse coupling,  $p_{\nu}$ , is the complement of having no transverse couplings, that is,

$$
p_{\nu} = 1 - (1 - \nu)^2.
$$
 (1)

Given an arbitrary dysfunctional cell  $i$ , let  $\ell_i$  denote the distance (measured in number of links) from that cell to its first neighbour to the right that has at least one transverse coupling. Hence, the probability that  $\ell_i < \ell_{\min}$ 

$$
P\left(\ell_i < \ell_{\min}\right) = \sum_{\ell_i=0}^{\ell_{\min}-1} (1 - p_{\nu})^{\ell_i} p_{\nu} = 1 - (1 - p_{\nu})^{\ell_{\min}} = 1 - (1 - \nu)^{2\ell_{\min}},\tag{2}
$$

that is, the complement satisfies

$$
P(l \ge \ell_{\min}) = (1 - \nu)^{2\ell_{\min}}.\tag{3}
$$

A micro re-entry circuit may not form if the path length of the potential reentry circuit is less than the refractory period. That happens when  $\ell_{\min} = \tau / 2$ (for even  $\tau$ ) and we find that

$$
P\left(l_i < \frac{\tau}{2}\right) = 1 - (1 - \nu)^{\tau} \,. \tag{4}
$$

The average number of dysfunctional cells in a system is given by  $\delta L^2$ .  $P_{\rm risk}$ is the complement of all dysfunctional cells having  $l_i < \frac{7}{2}$  $\frac{\tau}{2}$ , that is,

$$
P_{\text{risk}} = 1 - \prod_{\text{dysfct.}} P(\ell_i < \ell_{\text{min}}) = 1 - [1 - (1 - \nu)^{\tau}]^{\delta L^2} \,. \tag{5}
$$

In the calculation above, we have treated all sites equally, that is, we have ignored boundary effects. We will now redo the calculation rigorously in a finite system. The finiteness of the system implies that for a given dysfunctional cell *i*, there is a maximum distance  $L - i$  to its first neighbour to the right that has at least one transverse couplings. Hence

$$
P\left(\ell_{i} \geq \ell_{\min}\right) = \begin{cases} \sum_{\ell_{i}=\ell_{\min}}^{L-1} (1 - p_{\nu})^{\ell_{i}} p_{\nu} & \text{for } \ell_{\min} \leq L - i \\ 0 & \text{for } \ell_{\min} > L - i \end{cases}
$$

$$
= \begin{cases} (1 - p_{\nu})^{\ell_{\min}} - (1 - p_{\nu})^{L - i + 1} & \text{for } \ell_{\min} \leq L - i \\ 0 & \text{for } \ell_{\min} > L - i, \end{cases}
$$
(6)

and we find that

$$
P\left(\ell_i < \ell_{\min}\right) = \begin{cases} 1 - (1 - \nu)^{2\ell_{\min}} - (1 - \nu)^{2(L - i + 1)} & \text{for } \ell_{\min} \le L - i \\ 1 & \text{for } \ell_{\min} > L - i. \end{cases} \tag{7}
$$

A reentrant circuit may not form if the path length of the circuit is less than the refractory period. That happens when  $\ell_{\min} = \tau / 2$ . The probability that all dysfunctional cells have  $\ell_i < \frac{\tau_i}{2}$  $\frac{\tau}{2}$  is given by  $\prod_{\text{dysfct.}} P\left(\ell_i < \tau/2\right)$ . Note, however, that only dysfunctional cells with with  $i = 1, \ldots, L - \tau/2$  contribute with a factor less than one. For each  $i = 1, \ldots, L$ , the average number of dysfuncitonal cells is  $\delta L$ . Hence, the risk that a system has at least one critical region is given by

$$
P_{\text{risk}} = 1 - \prod_{\text{dysfct.}} P(\ell_i < \tau/2)
$$
\n
$$
= 1 - \prod_{i=1}^{L-\tau/2} \left[ 1 - (1 - \nu)^{\tau} - (1 - \nu)^{2(L-i+1)} \right]^{\delta L} . \tag{8}
$$

Note that for  $\nu = 1$  and  $\nu = 0$ ,  $P_{\text{risk}} = 0$  for all values of  $\delta L \neq 0$  and that  $P_{\text{risk}} = 0$  when no dysfunctional cells are present,  $\delta = 0$ . It is also interesting to note that for  $0 < \nu < 1$ ,

$$
\lim_{L \to \infty} P_{\text{risk}} = 1,\tag{9}
$$

that is, the quite abrupt transition from normal heart rhythm to fibrilatory behaviour seen when the fraction of transverse connections decreases below a critical value is technically an effect of the system having finite size. Unusually, though, as we will prove below, this finite-size effect disappear extremely slowly and hence it is physically relevant for all system sizes and is even present for systems with an area the size of the Earth.

#### **Estimating the threshold for fraction of transverse connections** ν

We define the threshold for the fraction of transverse connections as the value of  $\nu^*$  where the slope of the graph of  $P_{\text{risk}}$  vs.  $\nu$  is steepest. For simplicity, we consider the result where boundary effects are ignored, that is,

$$
P_{\text{risk}} = 1 - [1 - (1 - \nu)^{\tau}]^{\delta L^2}.
$$
 (10)

We are searching for the non-trivial  $\nu^\star$  that solves  $\frac{\partial^2 P_\text{risk}}{\partial \nu^2}=0$  We find that

$$
\frac{\partial P_{\text{risk}}}{\partial \nu} = -\delta L^2 \left[ 1 - (1 - \nu)^{\tau} \right]^{\delta L^2 - 1} \tau \left( 1 - \nu \right)^{\tau - 1} . \tag{11}
$$

Hence,  $\frac{\partial P_{\text{risk}}}{\partial \nu} < 0$  for  $0 < \nu < 1$  implying that  $P_{\text{risk}}$  is a monotonic decreasing function of  $\nu$ . We find that

$$
\frac{\partial^2 P_{\text{risk}}}{\partial \nu^2} = -\delta L^2 \left[ 1 - (1 - \nu)^{\tau} \right]^{\delta L^2 - 2} \tau \left( 1 - \nu \right)^{\tau - 2} \left[ \left( \delta L^2 - 1 \right) \tau \left( 1 - \nu \right)^{\tau} - \left[ 1 - (1 - \nu)^{\tau} \right] (\tau - 1) \right]. \tag{12}
$$

Therefore,

$$
\frac{\partial^2 P_{\text{risk}}}{\partial \nu^2} = 0 \Leftrightarrow \nu = \begin{cases} 0\\ 1 \end{cases}
$$
 (13)

or that  $\nu^*$  satisfies the equation

$$
(\delta L^2 - 1) \tau (1 - \nu^*)^{\tau} - (\tau - 1) + (1 - \nu^*)^{\tau} (\tau - 1) = 0.
$$
 (14)

We solve this equation with respect to  $1 - \nu^*$ :

$$
1 - \nu^* = \left(\frac{\tau - 1}{\delta L^2 \tau - 1}\right)^{1/\tau} \approx (\delta L^2)^{-1/\tau},\tag{15}
$$

because to a good approximation,  $\tau \gg 1$  and  $\delta L^2 \tau \gg 1$ . Setting  $\delta = 0.05, \tau = 1$ 50 and  $L = 200$ , we estimate the threshold  $\nu^*$  where  $P_{\text{risk}}$  picks up quite abruptly to be at

$$
1 - \nu^* \approx 0.86 \Leftrightarrow \nu^* \approx 0.14. \tag{16}
$$

It is interesting to note that the threshold approaches 1 like  $L^{-2/\tau}$ , that is, extremely slowly. For example, the threshold reaches  $v^* = 0.63$  for  $L =$  $5 \times 10^{11}$ , corresponding to an atria with an area the size of the Earth. Hence, although the transition is technically a finite-size effect, it is relevant for all system sizes and only disappears when  $L = \infty$ .

#### **3D Sheet**

We now calculate  $P_{\text{risk}}$  for multiple sheets. Consider w parallel sheets of size  $L \times L$ . Each sheet has periodic boundary conditions transversally and open boundary conditions longitudinally. This results in a cylindrical topology with cylinder thickness  $w$ . The probability that a cell has at least one transverse coupling,  $p_{\nu}$ , is the complement of having no transverse couplings, that is,

$$
p_{\nu} = 1 - (1 - \nu)^n, \tag{17}
$$

where  $n = 3$  if a cell is at the surface and  $n = 4$  if the cell is within the bulk of the tissue.

The probability that an arbitrary dysfunctional cell, *i*, is a distance  $\ell_i$  <  $\ell_{\min}$  becomes:

$$
P\left(\ell_i < \ell_{\min}\right) = 1 - \left(1 - p_\nu\right)^{n\ell_{\min}}\tag{18}
$$

So the probability that all dysfunctional cells (on average  $\delta w(L-2)^2$ ) have  $\ell_i < \ell_{\min} = \frac{\tau}{2}$  $rac{\tau}{2}$  is

$$
P_{\text{risk}} = 1 - \prod_{\substack{\text{dystet.} \\ \text{cells}}} P\left(\ell_i < \frac{\tau}{2}\right) = 1 - \left[1 - (1 - \nu)^{\frac{3}{2}\tau}\right]^{2\delta L^2} \left[1 - (1 - \nu)^{2\tau}\right]^{(w - 2)\delta L^2}
$$
\n(19)

The curve still shows a sudden transition (see supplementary Fig. 1). We show this for  $\delta = 0.05, \tau = 50, w = 7$  and  $L = 200$ .



Figure 1: The probability that a three dimensional substrate, that is, a cylinder with finite thickness, develops AF,  $P_{\text{risk}}$ . A sudden transition as the transversal coupling is varied remains.

# **Additional Figures**

The figures shown in the manuscript were enlarged subsections of the full system size. For completeness we include the images for the full system size.



**Figure 2:** The initiation and termination of a re-entry circuit. This is the full  $200 \times 200$  system of the sub-section show in Fig. 2 of the manuscript.



**Figure 3:** Complexity of wave behaviour at different levels of vertical coupling. This is the full 200  $\times$  200 system of the sub-section show in Fig. 3 of the manuscript.



**Figure 4:** A region of tissue is made unexcitable simulating ablation. This is the full  $200 \times 200$ system of the sub-section show in Fig. 4 of the manuscript.